Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/779,651	JOUNG, TAE-YEOL	
Examiner	Art Unit	
John Fox	3753	

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SEARCHED					
Class	Subclass	Date	Examiner		
127	1-6-				
137	625.47	,			
	625.47 375	8/05	#		
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS search	8/05	JF.		
mierter nave search	8/05	F		
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